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Enhancing the Security of Smart Grid Networks

Guest Editors:

Prof. Dr. Jin Cao

Prof. Dr. Yinghui Zhang

Prof. Dr. Maode Ma

Dr. Ruhui Ma

Deadline for manuscript submissions:

closed (31 July 2023)

Message from the Guest Editors

this Special Issue will invite and collect security/risk detection, analysis, assessment technology, authentication, secure data transmission and privacy preservation technologies related to the smart grid networks.

Potential topics include, but are not limited to, the following:

- Risk analysis and assessment technology in smart grid networks;
- Access to security detection technology for service terminals in smart grid networks;
- Edge equipment security detection technology in smart grid networks;
- Network transmission security detection technology in smart grid networks;
- Security detection tools in smart grid networks;
- New access authentication protocols with privacy preservation for smart grid networks;
- Authentication and privacy protection for smart grid networks;
- Slicing security and privacy protection for smart grid networks;
- End-to-end security for smart grid networks;
- Physical layer security for smart grid networks;
- Artificial Intelligence and Machine Learning for smart grid networks.

Welcome to contribute.

Specialsue









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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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